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_	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/507,220	OHMI ET AL.	
	Examiner	Art Unit	
	Aaron M. Dunwoody	3679	

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Class	Subclass	Date	Examiner
277	644,630, 637,925, 608,609, 616	2/8/2006	AMD
277	626	2/8/2006	AMD
285	328,354	2/8/2006	AMD
385	917	2/8/2006	AMD
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INT	ITERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

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